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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/904,317	OHATA ET AL.	
Examiner	Art Unit	
Madeleine AV Nauven	2625	

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Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East	2/2/2007	AV	